



## **Typical Applications**

The HMC999 is ideal for:

- Test Instrumentation
- Military Communications
- Jammers and Decoys
- Radar, EW & ECM Subsystems
- Space

#### **Features**

High P1dB Output Power: 38 dBm High Psat Output Power: 40 dBm

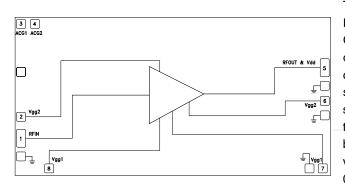
High Output IP3: 47 dBm

High Gain: 11 dB

Supply Voltage: +28V, +40V or +48V @ 1100 mA

50 Ohm Matched Input/Output Die Size: 3.66 x 1.91 x 0.1 mm

## **Functional Diagram**



### **General Description**

The HMC999 is a GaN HEMT MMIC Distributed Power Amplifier which operates between 0.01 and 10 GHz. The amplifier provides 11 dB of gain, 47 dBm output IP3 and 38 dBm of output power at 1 dB gain compression while requiring 1100 mA from a +48 V supply. The HMC999 amplifier provides 10 Watts of saturated power in a chip area only 7 mm², equating to a power density of 1.5 W/mm² over 3 decades of bandwidth. All data is taken with the chip connected via two 0.025 mm (1 mil) wire bonds of minimal length 0.31 mm (12 mils).

# Electrical Specifications, $T_A = +25$ °C <sup>[2]</sup>, Vdd = +48 V, Vgg2 = +22 V, Idd = 1100 mA\* <sup>[1]</sup>

Parameter	Min.	Тур.	Max.	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
Frequency Range		0.01 - 2			2 - 6			6 - 10		GHz
Gain	10.5	12.5		9	11		8.5	10.5		dB
Gain Flatness		±0.8			±0.4			±0.7		dB
Gain Variation Over Temperature		0.017			0.02			0.025		dB/ °C
Input Return Loss		20			18			15		dB
Output Return Loss		13			15			14		dB
Output Power for 1 dB Compression (P1dB)	36.5	38.5		36	38		34.5	36.5		dBm
Saturated Output Power (Psat)		40.5			40			39.5		dBm
Output Third Order Intercept (IP3)		48			47			45.5		dBm
Supply Current (Idd) (Vdd = 48V, Vgg = 22V Typ.)		1100			1100			1100		mA

<sup>\*</sup> Adjust Vgg1 between -5 to 0 V to achieve Idd = 1100 mA typical.

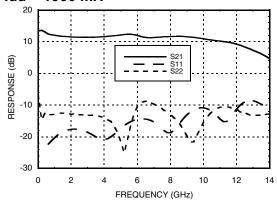
<sup>[1]</sup> S parameter and OIP3 data taken at Idd=1000mA

<sup>[2]</sup> Probe station chuck temperature adjusted to bring backside of die to +25°C

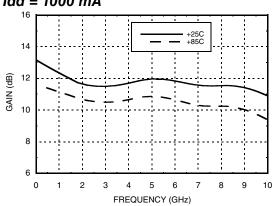




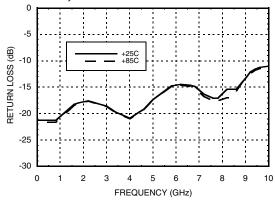
Gain & Return Loss @ Vdd = 48V, Idd = 1000 mA



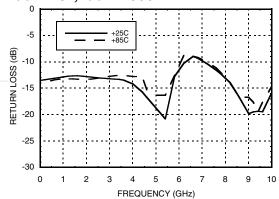
Gain vs. Temperature @ Vdd = 48V, Idd = 1000 mA



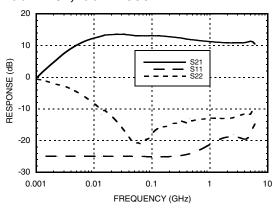
Input Return Loss vs. Temperature @ Vdd =48V, Idd = 1000 mA



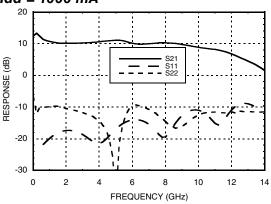
Output Return Loss vs. Temperature @ Vdd = 48V, Idd = 1000 mA



Low Frequency Gain & Return Loss @ Vdd = 48V, Idd = 1000 mA



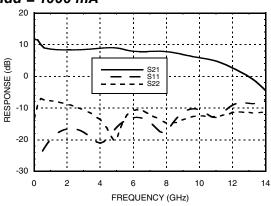
Gain & Return Loss @ Vdd = 40V, Idd = 1000 mA



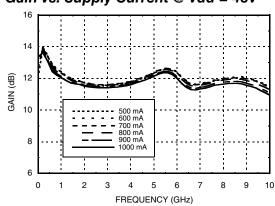




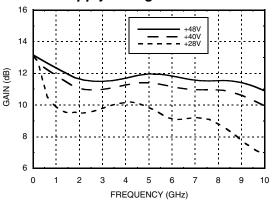
Gain & Return Loss @ Vdd = 28V, Idd = 1000 mA



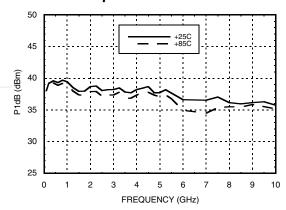
Gain vs. Supply Current @ Vdd = 48V



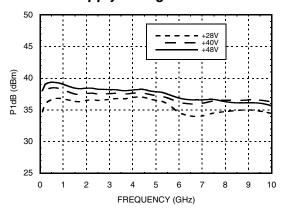
Gain vs. Supply Voltage @ Idd = 1000 mA



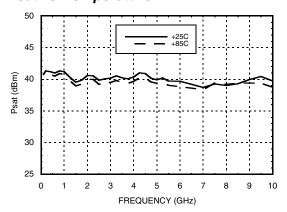
P1dB vs. Temperature



P1dB vs. Supply Voltage



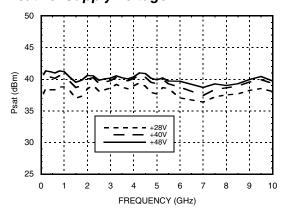
Psat vs. Temperature



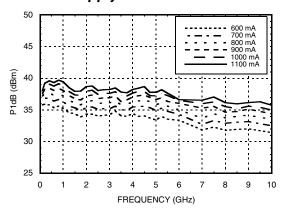




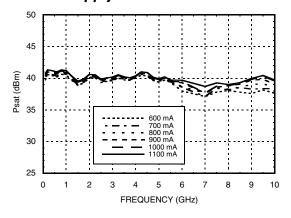
### Psat vs. Supply Voltage



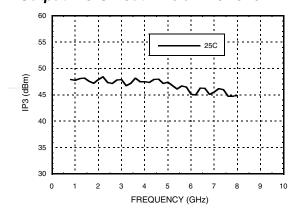
### P1dB vs. Supply Current



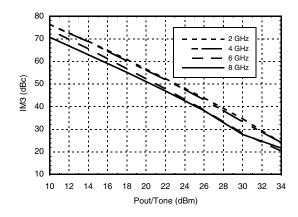
### Psat vs. Supply Current



## Output IP3 @ Pout = 26 dBm / Tone



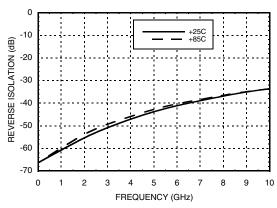
### Output IM3 @ Vdd = +48V



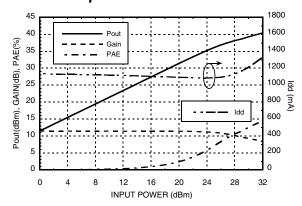




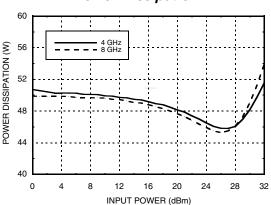
## Reverse Isolation vs. Temperature



### Power Compression @ 4 GHz



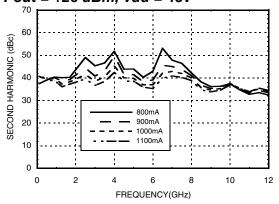
### **Power Dissipation**



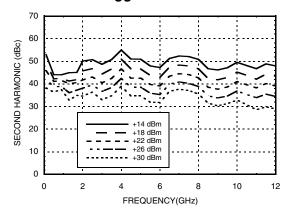




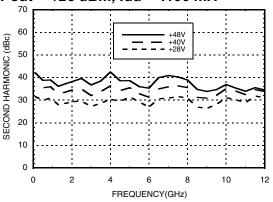
# Second Harmonics vs. Idd @ Pout = +26 dBm, Vdd = 48V



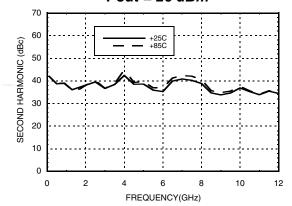
## Second Harmonics vs. Pout Vdd = 48V & Vgg = 22V & Idd = 1100 mA



# Second Harmonics vs. Vdd @ Pout = +26 dBm, Idd = 1100 mA



### Second Harmonics vs. Temperature Vdd = 48V & Vgg = 22V & Idd = 1100 mA Pout = 26 dBm



## **Absolute Maximum Ratings**

56V
-5 to 0V
6V to (Vdd - 8V)
28 dBm
36 dBm
225 °C
102 W
1.37 °C/W
40 dBm
-65 to 150 °C
-55 to 85 °C



## Typical Supply Current vs. Vdd

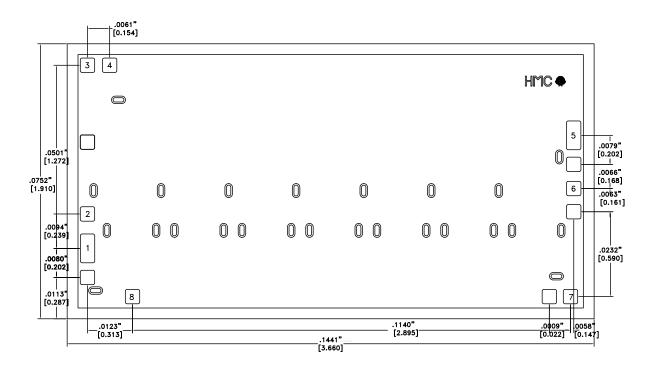
Vdd (V)	Idd (mA)
28	1100
40	1100
48	1100

[1] Includes 0.5 mil thick thermally conductive epoxy layer. Epoxy thermal conductivity = 60 W/mC





### **Outline Drawing**



### Die Packaging Information [1]

Standard	Alternate		
GP-1 (Gel Pack)	[2]		

[1] Refer to the "Packaging Information" section for die packaging dimensions.

[2] For alternate packaging information contact Hittite Microwave Corporation.

#### NOTES

- 1. ALL DIMENSIONS IN INCHES [MILLIMETERS]
- 2. DIE THICKNESS IS 0.004 (0.100)
- 3. TYPICAL BOND PAD IS 0.004 (0.100) SQUARE
- 4. BOND PAD METALIZATION: GOLD
- 5. BACKSIDE METALLIZATION: GOLD
- 6. BACKSIDE METAL IS GROUND
- 7. NO CONNECTION REQUIRED FOR UNLABELED BOND PADS
- 8. OVERALL DIE SIZE IS  $\pm .002$





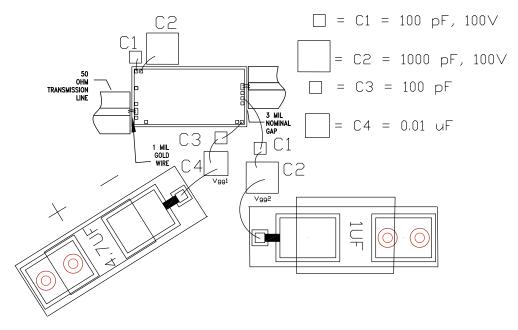
### **Pad Descriptions**

Pad Number	Function	Description	Interface Schematic
1	RFIN	This pad is DC coupled and matched to 50 Ohms. External blocking capacitor is required	RFIN O
2, 6	VGG2	Gate control 2 for amplifier. Attach bypass capacitor per application circuit herein. For nomiinal operation +22V should be applied to either pad 2 or pad 6.	VGG2 0
3, 4	AGC1, AGC2	Low frequency termination. Attach bypass capacitor per application circuit herein.	ACG1 O
5	RFOUT & VDD	RF output for amplifier. Connect DC bias (Vdd) network to provide drain current ldd). See application circuit herein.	4002
7, 8	VGG1	Gate control 1 for amplifier. Attach bypass capacitor per application circuit herein. Please follow "MMIC Amplifier Biasing Procedure" application note. This voltage may be applied to either pad 7 or pad 8.	VGG1 0
Die Bottom	GND	Die bottom must be connected to RF/DC ground	

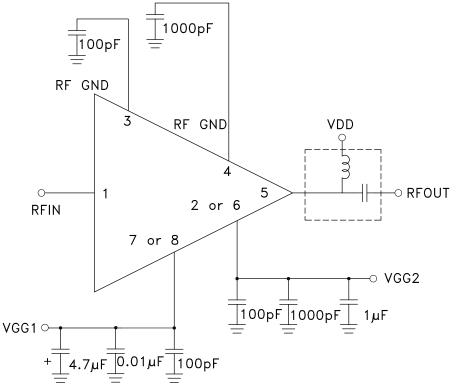




## **Assembly Diagram**



# **Application Circuit**



NOTE 1: Drain Bias (Vdd) must be applied through a broadband bias tee with low series resistance and capable of providing ~1800 mA





0.076mm

(0.003")

Copper Tungster

## Mounting & Bonding Techniques for Millimeterwave GaN MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick copper tungsten heat spreader which is then attached to the thermally conductive ground plane (Figure 2).

Microstrip substrates should be placed as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm to 0.152 mm (3 to 6 mils).

### **Handling Precautions**

Follow these precautions to avoid permanent damage.

**Storage:** All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

**Cleanliness:** Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against ESD strikes.

**Transients:** Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pickup.

0.127mm (0.005") Thick Alumina
Thin Film Substrate
Figure 1.

0.102mm (0.004") Thick GaN MMIC

Wire Bond

0.076mm
(0.003")

RF Ground Plane

0.150mm (0.005") Thick

Figure 2.

0.254mm (0.010") Thick Alumina

Thin Film Substrate

0.102mm (0.004") Thick GaN MMIC

RF Ground Plane

Wire Bond

**General Handling:** Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip may have fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

### Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

### Wire Bonding

RF bonds made with two 1 mil wires are recommended. These bonds should be thermosonically bonded with a force of 40-60 grams. DC bonds of 0.001" (0.025 mm) diameter, thermosonically bonded, are recommended. Ball bonds should be made with a force of 40-50 grams and wedge bonds at 18-22 grams. All bonds should be made with a nominal stage temperature of 150 °C. A minimum amount of ultrasonic energy should be applied to achieve reliable bonds. All bonds should be as short as possible, less than 12 mils (0.31 mm).